

Search Notes



Application/Control No.

10/500,736

Examiner

Sang Y. Paik

Applicant(s)/Patent under Reexamination

KACHI ET AL.

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
219	443.1 444.1 390		
392	448		
118	724 725		
updated on 5/12/06 1P			
		5/12/06	1P
		12/21/06	Y

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
GRAT TERS EXTENDED	8/24/05	Y